

# AON1634

# 30V N-Channel MOSFET

# **General Description**

The AON1634 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{\text{DS(ON)}}.$  This device is ideal for load switch and battery protection applications.

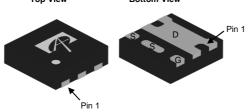
# **Product Summary**

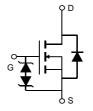
 $\begin{array}{lll} V_{DS} & 30V \\ I_{D} & (at \, V_{GS} \! = \! 10V) & 4A \\ R_{DS(ON)} & (at \, V_{GS} = \! 10V) & < 54m\Omega \\ R_{DS(ON)} & (at \, V_{GS} = \! 4.5V) & < 62m\Omega \\ R_{DS(ON)} & (at \, V_{GS} = \! 2.5V) & < 82m\Omega \end{array}$ 

Typical ESD protection HBM Class 3A









Absolute Maximum Ratings T<sub>A</sub>=25℃ unless otherwise noted Parameter Symbol Maximum Units Drain-Source Voltage 30  $V_{DS}$ ٧ Gate-Source Voltage ±12  $V_{GS}$ Continuous Drain T<sub>A</sub>=25℃ 4  $I_D$ Current G T<sub>A</sub>=70℃ 3 Α Pulsed Drain Current C 16  $I_{\text{DM}}$ T<sub>A</sub>=25℃ 1.8  $P_D$ W T<sub>A</sub>=70℃ Power Dissipation A 1.15 Junction and Storage Temperature Range  $T_J$ ,  $T_{STG}$ -55 to 150  ${\mathfrak C}$ 

| Thermal Characteristics        |              |                      |     |     |       |  |  |  |  |
|--------------------------------|--------------|----------------------|-----|-----|-------|--|--|--|--|
| Parameter                      |              | Symbol               | Тур | Max | Units |  |  |  |  |
| Maximum Junction-to-Ambient A  | t ≤ 10s      | D                    | 56  | 70  | °C/W  |  |  |  |  |
| Maximum Junction-to-Ambient AD | Steady-State | $\kappa_{\theta JA}$ | 88  | 110 | °C/W  |  |  |  |  |



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

| Symbol                | Parameter                             | Conditions   |       | Min | Тур  | Max | Units |  |
|-----------------------|---------------------------------------|--|-------|-----|------|-----|-------|--|
| STATIC                | PARAMETERS                            |  |       |     |      |     |       |  |
| BV <sub>DSS</sub>     | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                 |       | 30  |      |     | V     |  |
| I <sub>DSS</sub>      | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V                                  |       |     |      | 1   | μА    |  |
|                       |                                       | T  | J=55℃ |     |      | 5   |       |  |
| I <sub>GSS</sub>      | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±10V                                 |       |     |      | ±10 | μΑ    |  |
| $V_{GS(th)}$          | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_{D}=250\mu A$   |       | 0.7 | 1.05 | 1.5 | V     |  |
| I <sub>D(ON)</sub>    | On state drain current                | $V_{GS}$ =10V, $V_{DS}$ =5V  |       | 16  |      |     | Α     |  |
| R <sub>DS(ON)</sub> S | Static Drain-Source On-Resistance     | $V_{GS}$ =10V, $I_D$ =4A   |       |     | 43.5 | 54  | mΩ    |  |
|                       |                                       | T <sub>J</sub> =   | =125℃ |     | 68   | 84  | 11122 |  |
|                       | Static Drain-Source On-Ivesistance    | $V_{GS}$ =4.5V, $I_D$ =3A  |       |     | 48   | 62  | mΩ    |  |
|                       |                                       | $V_{GS}$ =2.5V, $I_D$ =2A  |       |     | 62   | 82  | mΩ    |  |
| g <sub>FS</sub>       | Forward Transconductance              | $V_{DS}$ =5V, $I_D$ =4A  |       |     | 15   |     | S     |  |
| $V_{SD}$              | Diode Forward Voltage                 | I <sub>S</sub> =1A,V <sub>GS</sub> =0V                                     |       |     | 0.75 | 1   | V     |  |
| I <sub>S</sub>        | Maximum Body-Diode Continuous Current |  |       |     |      | 2.5 | Α     |  |
| DYNAMI                | C PARAMETERS                          |  |       |     |      |     |       |  |
| C <sub>iss</sub>      | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                          |       |     | 245  |     | pF    |  |
| Coss                  | Output Capacitance                    |  |       |     | 35   |     | pF    |  |
| $C_{rss}$             | Reverse Transfer Capacitance          |  |       |     | 20   |     | pF    |  |
| $R_g$                 | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                           |       |     | 5.3  |     | Ω     |  |
| SWITCH                | ING PARAMETERS                        |  |       |     |      |     |       |  |
| Q <sub>g</sub> (10V)  | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =4A             |       |     | 5.7  | 10  | nC    |  |
| Q <sub>g</sub> (4.5V) | Total Gate Charge                     |  |       |     | 2.6  | 5   | nC    |  |
| $Q_{gs}$              | Gate Source Charge                    |  |       |     | 0.5  |     | nC    |  |
| $Q_{gd}$              | Gate Drain Charge                     |  |       |     | 1    |     | nC    |  |
| t <sub>D(on)</sub>    | Turn-On DelayTime                     | $V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =3.75 $\Omega$ , $R_{GEN}$ =3 $\Omega$ |       |     | 2    |     | ns    |  |
| t <sub>r</sub>        | Turn-On Rise Time                     |  |       |     | 3.5  |     | ns    |  |
| t <sub>D(off)</sub>   | Turn-Off DelayTime                    |  |       |     | 22   |     | ns    |  |
| t <sub>f</sub>        | Turn-Off Fall Time                    |  |       |     | 3.5  |     | ns    |  |
| t <sub>rr</sub>       | Body Diode Reverse Recovery Time      | I <sub>F</sub> =4A, dI/dt=500A/μs  |       |     | 6.5  |     | ns    |  |
| $Q_{rr}$              | Body Diode Reverse Recovery Charge    | <sub>E</sub> I <sub>F</sub> =4A, dI/dt=500A/μs                             |       |     | 7.5  |     | nC    |  |

A. The value of R<sub>BJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation P<sub>DSM</sub> is based on R <sub>BJA</sub> t ≤ 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial  $T_J = 25^{\circ} C$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

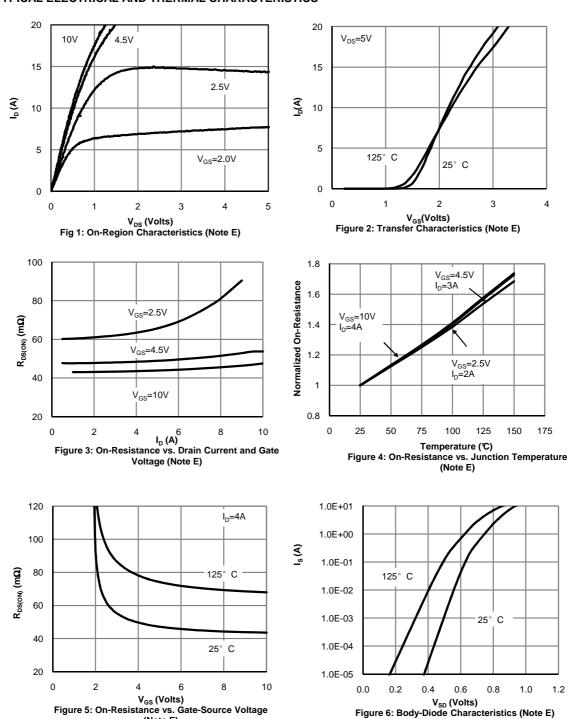
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



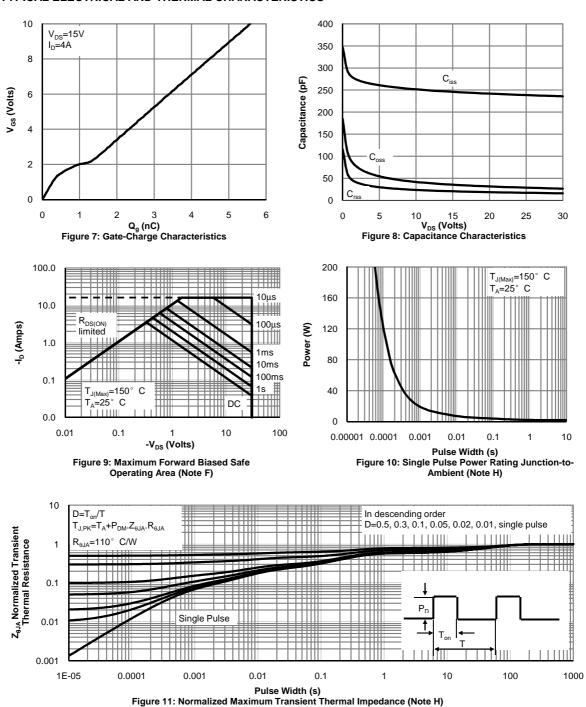
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)



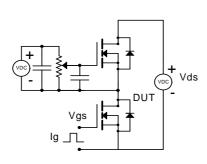


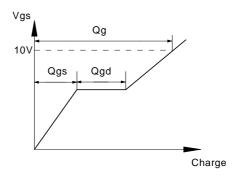
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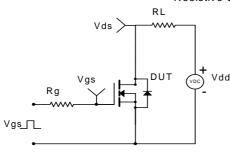


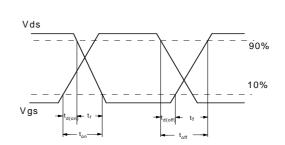
# Gate Charge Test Circuit & Waveform





# Resistive Switching Test Circuit & Waveforms





# Diode Recovery Test Circuit & Waveforms

